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### 1 [Validation and test generation for oscillatory noise in VLSI interconnects](#)

88%



Arani Sinha , Sandeep K. Gupta , Melvin A. Breuer

**Proceedings of the 1999 IEEE/ACM international conference on Computer-aided design**

November 1999

Inductance of on-chip interconnects gives rise to signal overshoots and undershoots that can cause logic errors. By considering technology trends, we show that in 0.13  $\mu\text{m}$  technology such noise in local interconnects embedded in combinational logic can exceed the threshold voltage. We show the impact of such noise on different kinds of circuits. The magnitude of this noise can increase due to process variations. We present an algorithm for generating vectors for ...

### 2 [Noise-aware power optimization for on-chip interconnect](#)

85%



Ki-Wook Kim , Seong-Ook Jung , Unni Narayanan , C. L. Liu , Sung-Mo Kang






**Proceedings of the 2000 international symposium on Low power electronics and design**

August 2000

Realization of high-performance domino logic depends strongly on energy-efficient and noise-tolerant interconnect design in ultra deep sub-micron processes. We characterize the cycle-averaged power model for interconnects accounting for switching statistics and dynamic behaviors. For the sake of signal integrity, cross-coupling effects are also characterized which reflect logical correlation between adjacent wires. Based on the new models for interconnect power and capacitive crosstalk, we ...

### 3 [Future Design Trends: A roadmap and vision for physical design](#)

80%

-  Andrew B. Kahng  
**Proceedings of the 2002 international symposium on Physical design** April 2002  
 This invited paper offers "roadmap and vision" for physical design. The main messages are as follows. (1) The high-level roadmap for physical design is static and well-known. (2) Basic problems remain untouched by fundamental research. (3) Academia should not overemphasize back-filling and formulation over innovation and optimization. (4) The physical design field must become more mature and efficient in how it prioritizes research directions and uses its human resources. (5) The scope of physi ...
- 4 Design issues for dynamic voltage scaling 80%  
 Thomas D. Burd , Robert W. Brodersen  
**Proceedings of the 2000 international symposium on Low power electronics and design** August 2000  
 Processors in portable electronic devices generally have a computational load which has time-varying performance requirements. Dynamic Voltage Scaling is a method to vary the processors supply voltage so that it consumes the minimal amount of energy by operating at the minimum performance level required by the active software processes. A dynamically varying supply voltage has implications on the processor circuit design and design flow, but with some minimal constraints it is straightforwa ...
- 5 Energy and Delay Considerations: Low swing dual threshold voltage domino logic 80%  
 Volkan Kursun , Eby G. Friedman  
**Proceedings of the 12th ACM Great Lakes Symposium on VLSI** April 2002  
 A low swing domino logic technique is proposed to decrease power consumption without sacrificing noise immunity. With the proposed low swing domino logic circuit technique, active power consumption is reduced by up to 9.4% while improving the noise immunity by 2.6% as compared to standard domino logic circuits. It is also shown that by applying a low swing contention reduction technique, the power savings can be further increased by 6.7% while the delay can be improved by 8.6%. A simple and effi ...
- 6 Wang Tiles for image and texture generation 77%  
 Michael F. Cohen , Jonathan Shade , Stefan Hiller , Oliver Deussen  
**ACM Transactions on Graphics (TOG)** July 2003  
 Volume 22 Issue 3  
 We present a simple stochastic system for non-periodically tiling the plane with a small set of Wang Tiles. The tiles may be filled with texture, patterns, or geometry that when assembled create a continuous representation. The primary advantage of using Wang Tiles is that once the tiles are filled, large expanses of non-periodic texture (or patterns or geometry) can be created as needed very efficiently at runtime. Wang Tiles are squares in which each edge is assigned a color. A valid tiling req ...
- 7 Rule-based VLSI verification system constrained by layout parasitics 77%  
 J. Wenin , J. Verhasselt , M. Van Camp , J. Leonard , P. Guebels  
**Proceedings of the 1989 26th ACM/IEEE conference on Design automation conference** June 1989  
 This paper addresses a rule-based method for VLSI design review, constrained by parasitics. Using the new ideas discussed in this paper, extraction from layout is not limited anymore to

conventional electrical data, but additionally allows modelling of functional and timing behaviour. An extendable rule based validation algorithm operates on extracted models, decorated with parasitic effects, to formally prove most aspects of design correctness.

- 8 Session 6C: Signal integrity and clock design: CASH: a novel "clock as shield" design methodology for noise immune precharge-evaluate logic 77%



Yonghee Im , Kaushik Roy

**Proceedings of the 2001 IEEE/ACM international conference on Computer-aided design**  
November 2001

In gigascale integrated circuits (GSI), interconnects are expected to play a more dominant role in circuit performance than transistor cells. The circuit performance is affected by signal integrity as cross-talk becomes more significant with the scaling of feature sizes. Many attempts have been made to improve noise immunity, but all require the sacrifice of speed as a trade-off, especially in dynamic circuits. Avoiding noise problems while maintaining the desired speed would involve increased w ...

- 9 Suggestions for a method of analyzing binary images using Langlet's parity logic 77%



Stuart Smith

**ACM SIGAPL APL Quote Quad , Proceedings of the 2001 conference on APL: an arrays odyssey** December 2000  
Volume 31 Issue 2

This paper describes an extension to the system of parity logic operations developed by Gerard Langlet and subsequently elaborated by Michael Zaus. Two operations, A and B, are introduced which can be used both to analyze and to synthesize arbitrary patterns of I's and O's in square Boolean matrices. The A and B operations are, like most of the operations in Langlet's system, completely reversible (i.e., the input to A or B can be exactly rec ...

- 10 New test methods targeting non-classical faults: A novel wavelet transform based transient current analysis for fault detection and localization 77%



Swarup Bhunia , Kaushik Roy , Jaume Segura

**Proceedings of the 39th conference on Design automation** June 2002

Transient current (IDD) based testing has been often cited and investigated as an alternative and/or supplement to quiescent current (IDDQ) testing. While the potential of IDD testing for fault detection has been established, there is no known efficient method for fault diagnosis using IDD analysis. In this paper, we present a novel integrated method for fault detection and localization using wavelet transform based IDD waveform analysis. The time-frequency resolution property of wavelet transfo ...

- 11 Future performance challenges in nanometer design 77%



Dennis Sylvester , Himanshu Kaul

**Proceedings of the 38th conference on Design automation** June 2001

We highlight several fundamental challenges to designing high-performance integrated circuits in nanometer-scale technologies (i.e. draRita Glover, EDA Today, L.C.wn feature sizes < 100 nm). Dynamic power scaling trends lead to major packaging problems. To alleviate these concerns, tMarc Halpernhermal monitoring and feedback mechanisms can limit worst-case dissipation and reduce costs. Furthermore, a flexible multi-Vdd + multi-Vth + re-sizing approach is advocated to leverage the inherent pr ...

- 12 False coupling interactions in static timing analysis 77%  
Ravishankar Arunachalam , Ronald D. Blanton , Lawrence T. Pileggi  
**Proceedings of the 38th conference on Design automation** June 2001  
Neighboring line switching can contribute to a large portion of the delay of a line for today's deep submicron designs. In order to avoid excessive conservatism in static timing analysis, it is important to determine if aggressor lines can potentially switch simultaneously with the victim. In this paper, we present a comprehensive ATPG-based approach that uses functional information to identify valid interactions between coupled lines. Our algorithm accounts for glitches on aggressors that ...
- 13 Is nanometer design under control? (panel session) 77%  
Andrew B. Kahng , Nancy Nettleton , John Cohn , Shekhar Borkar , Louis Scheffer , Ed Cheng , Sang Wang  
**Proceedings of the 38th conference on Design automation** June 2001  
As fabrication technology moves to 100 nm and below, profound nanometer effects become critical in developing silicon chips with hundreds of millions of transistors. Both EDA suppliers and system houses have been re- tooling, and new methodologies have been emerging. Will these efforts meet the challenges of nanometer silicon such as performance closure, power, reliability, manufacturability, and cost? Which aspects of nanometer design are, or are not, under control? This session will consi ...
- 14 Transistor sizing for reliable domino logic design in dual threshold voltage technologies 77%  
Seong-Ook Jung , Ki-Wook Kim , Sung-Mo Steve Kang  
**Proceedings of the 11th Great Lakes Symposium on VLSI** March 2001
- 15 Reliability Issues in Computing System Design 77%  
B. Randell , P. Lee , P. C. Treleaven  
**ACM Computing Surveys (CSUR)** June 1978  
Volume 10 Issue 2
- 16 Studies in machine cognition using the game of poker 77%  
Nicholas V. Findler  
**Communications of the ACM** April 1977  
Volume 20 Issue 4  
A progress report is presented of on-going research efforts concerning human decision making under uncertainty and risk and human problem solving and learning processes on the one hand, and machine learning, large scale programming systems, and novel programming techniques on the other. There has also been interest in how humans make deductive and inductive inferences and form and optimize heuristic rules, and how machines can reach similar results. Although the vehicle of these investigati ...
- 17 Curriculum 68: Recommendations for academic programs in computer science: a report of the 77%  
ACM curriculum committee on computer science  
William F. Atchison , Samuel D. Conte , John W. Hamblen , Thomas E. Hull , Thomas A. Keenan , William B. Kehl , Edward J. McCluskey , Silvio O. Navarro , Werner C. Rheinboldt ,

**18** Teaching C++ in a multi-user virtual environment

77%



J. Mark Pullen , Eugene Norris , Mark Fix

**ACM SIGCSE Bulletin** June 2000

Volume 32 Issue 2

The Internet has opened tremendous possibilities for distance education, where teachers and students can be distributed worldwide. However, much of today's Internet-based teaching is limited to student access of Web-based multimedia documents. In this paper we describe new dimensions in distributed education that are possible in synchronous sessions where the students interact with the teacher in real time. We review and elaborate on the nature of the MUVE, a spatially oriented, network-accessed ...

**19** ClariNet: a noise analysis tool for deep submicron design

77%



Rafi Levy , David Blaauw , Gabi Braca , Aurobindo Dasgupta , Amir Grinshpon , Chanlee Oh , Boaz Orshav , Supamas Sirichotiyakul , Vladimir Zolotov

**Proceedings of the 37th conference on Design automation** June 2000

Coupled noise analysis has become a critical issue for deep-submicron, high performance design. In this paper, we present, ClariNet, an industrial noise analysis tool, which was developed to efficiently analyze large, high performance processor designs. We present the overall approach and tool flow of ClariNet and discuss three critical large-processor design issues which have received limited discussion in the past. First, we present how the driver gates of a coupled interconnect network a ...

**20** &ldquo;Timing closure by design,&rdquo; a high frequency microprocessor design methodology

77%



S. Posluszny , N. Aoki , D. Boerstler , P. Coulman , S. Dhong , B. Flachs , P. Hofstee , N. Kojima , O. Kwon , K. Lee , D. Meltzer , K. Nowka , J. Park , J. Peter , J. Silberman , O. Takahashi , P. Villarrubia

**Proceedings of the 37th conference on Design automation** June 2000

This paper presents a design methodology emphasizing early and quick timing closure for high frequency microprocessor designs. This methodology was used to design a Gigahertz class PowerPC microprocessor with 19 million transistors. Characteristics of &ldquo;Timing Closure by Design are 1) logic partitioned on timing boundaries, 2) predictable control structures (PLAs), 3) static interfaces for dynamic circuits, 4) low skew clock distribution, 5) deterministic method of macro placement, 6) ...

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*Shakeri, K.; Meindl, J.D.;*

ASIC/SOC Conference, 2002. 15th Annual IEEE International , 25-28 Sept. 2002  
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**2 Crosstalk fault reduction and simulation for clock-delayed domino circ**

*Shimizu, K.; Itazaki, N.; Kinoshita, K.;*

Test Symposium, 2002. (ATS '02). Proceedings of the 11th Asian , 18-20 Nov. 2  
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**3 Dynamic logic styles with improved noise-immunity**

*Mendoza-Hernandez, F.; Linarea, M.; Champac, V.H.;*

Devices, Circuits and Systems, 2002. Proceedings of the Fourth IEEE Internation  
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**4 Optimal timing for skew-tolerant high-speed domino logic**

*Seong-Ook Jung; Ki-Wook Kim; Sung-Mo Kang;*

VLSI, 2003. Proceedings. IEEE Computer Society Annual Symposium on , 25-26  
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**5 Noise constrained transistor sizing and power optimization for dual V/  
domino logic**

*Seong-Ook Jung; Ki-Wook Kim; Sung-Mo Kang;*

Very Large Scale Integration (VLSI) Systems, IEEE Transactions on , Volume: 10  
5 , Oct. 2002

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**6 Robustness of sub-70 nm dynamic circuits: analytical techniques and s  
trends**

*Anders, M.; Krishnamurthy, R.; Spotten, R.; Soumyanath, K.;*

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**7 Testing of dynamic logic circuits based on charge sharing**

*Heragu, K.; Sharma, M.; Kundu, R.; Blanton, R.D.;*

VLSI Test Symposium, 19th IEEE Proceedings on. VTS 2001 , 29 April-3 May 20

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**8 Variable threshold voltage keeper for contention reduction in dynamic  
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*Kursun, V.; Friedman, E.G.;*

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**9 Fault simulation method for crosstalk faults in clock-delayed domino C  
circuits**

*Shimizu, K.; Takamura, M.; Shirai, T.; Itazaki, N.; Kinoshita, K.;*

Electronic Design, Test and Applications, 2002. Proceedings. The First IEEE  
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**10 Test vector generation for charge sharing failures in dynamic logic**

*Heragu, K.; Sharma, M.; Kundu, R.; Blanton, R.D.;*

Computer-Aided Design of Integrated Circuits and Systems, IEEE Transactions on  
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**11 A contention-free domino logic for scaled-down CMOS technologies with ultra low threshold voltages**

*Elraba, M.E.S.; Anis, M.H.; Elmasry, M.I.;*

Circuits and Systems, 2000. Proceedings. ISCAS 2000 Geneva. The 2000 IEEE International Symposium on , Volume: 1 , 28-31 May 2000

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**12 Synthesis of CMOS domino circuits for charge sharing alleviation**

*Ching-Hwa Cheng; Shih-Chieh Chang; Shin-De Li; Wen-Ben Jone; Jinn-Shyan W*

Computer Aided Design, 2000. ICCAD-2000. IEEE/ACM International Conference  
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**13 CASH: a novel "Clock As Shield" design methodology for noise immune precharge-evaluate logic**

*Yonghee Im; Roy, K.;*

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**15 GateMaker: a transistor to gate level model extractor for simulation, automatic test pattern generation and verification**

*Kundu, S.;*

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**16 Noise-tolerant dynamic circuit design**

*Lei Wang; Shanbhag, N.R.;*

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**17 Design of domino CMOS cells under delay constraint**

*Zamudio, A.; Champac, V.H.; Sarmiento-Reyes, A.;*

Design of Mixed-Mode Integrated Circuits and Applications, 1999. Third International Workshop on , 26-28 July 1999

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**18 Energy-efficiency bounds for noise-tolerant dynamic circuits**

*Shanbhag, N.R.; Wang, L.;*

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**19 Skew-tolerant high-speed (STHS) domino logic**

*Seong-Ook Jung; Seung-Moon Yoo; Ki-Wook Kim; Sung-Mo Kang;*

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**20 Sub-Domino logic: ultra-low power dynamic sub-threshold digital logic**

*Soeleman, H.; Roy, K.; Paul, B.;*

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**21 An energy-efficient noise-tolerant dynamic circuit technique**

*Wang, L.; Shanbhag, N.R.;*

Circuits and Systems II: Analog and Digital Signal Processing, IEEE Transaction

Volume: 47 Issue: 11 , Nov 2000

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**22 Timing constraints for domino logic gates with timing-dependent kee**

*Seong-Ook Jung; Ki-Wook Kim; Sung-Mo Kang;*

Computer-Aided Design of Integrated Circuits and Systems, IEEE Transactions o

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